

Notice of References Cited		Application/Control No. 10/568,114	Applicant(s)/Patent Under Reexamination FUJII ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0196119	10-2004	Shibahara et al.	333/193
*	B	US-5,592,135	01-1997	Taguchi et al.	333/193
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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